Research Paper

Synthesis of Transition Metal Disulfides with Liquid Ammonium Sulfide as a Reliable Sulfur Precursor

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Abstract

We introduce liquid ammonium sulfide as a reliable and carbon-free sulfur precursor for synthesizing large-area transition metal disulfides (TMdS) in chemical vapor deposition. The flux of sulfur during TMdS growth is precisely controlled by passing a known amount of carrier gas through a bubbling system containing liquid ammonium sulfide. However, controlling the flux of sulfur through the conventional evaporation of sulfur powder using a heating belt remains a challenge. By achieving controllability of sulfur flux, we study growth kinetics such as nucleation density and growth rate. Furthermore, the continuous supply of the sulfur precursor results in the growth of a large-area monolayer and a few layers of MoS$_2$ film. In addition, we present the feasibility of ammonium sulfide as an effective and clean precursor for the growth of a wide range of TMdS, thus enabling it to serve as a universal sulfur precursor.

Keywords: Two-dimensional materials, Transition metal dichalcogenides, Chemical vapor deposition, Precursor, Ammonium sulfide

I. Introduction

Since the discovery of graphene in 2004 [1], two dimensional (2D) materials have been highlighted due to their unique physical and chemical properties such as exceptional high carrier mobility, gigantic magnetoresistance, and thickness-dependent electronic structural changes [2-8], which were not observed in bulk materials. These unique properties allow the developing of unprecedented electronic devices and new functionality of conventional devices with integrated 2D materials [9,10]. Theoretical calculation predicts that 350 monolayer 2D materials are stable at room temperature under ambient atmosphere [11]. The electronic structures of various 2D materials strongly depend on the constituent elements in 2D layer and their thickness [12]. For instance, while graphene consists of carbon atoms in hexagonal lattice and exhibits semimetallic property, hexagonal boron nitride (hBN) composed of boron and nitrogen atoms in hexagonal lattice is an insulator with energy band gap of ~ 6 eV. In addition, transition metal dichalcogenides (TMdCs) which consists of transition metal and chalcogen atoms exhibits metallic or semiconducting properties. Furthermore, the energy band gaps of TMdCs varies with thickness due to the orbital interaction between layers [13].

To apply these 2D materials in numerous devices, large-area and high-quality 2D materials are highly necessary. Chemical vapor deposition (CVD) is one of the promising methods in terms of high throughput, low cost and high crystallinity for the growth of wafer-scale 2D materials [14,15]. This is evident in the number of research conducted over the past decade to grow 2D materials via CVD [16-20]. Recently, wafer-scale single-crystal graphene and hBN have been successfully synthesized via “epitaxial growth” and “self-collimated growth” on single crystal Cu (111) and liquid Au substrates, respectively. These growths were made possible due to the presence of reliable vapor and liquid phase precursors, which allowed precise controlling of...
the precursors [21,22]. By contrast, the precursors for growth of TMdCs are quite limited to solid-phase precursors due to the absence of vapor or liquid phase alternatives [17-19]. Typically, solid phase precursors such as metal oxides MoO$_3$ and WO$_3$ and chalcogen powders such as S, Se and Te are supplied by evaporating with local heating, restricting the continuous and simultaneous supply of precursors. This limits the reproducible and reliable growth of TMdCs. To overcome this problem, volatile metal carbonyls such as Mo(CO)$_6$ and W(CO)$_6$ and liquid organochalcogen compounds such as $\text{C}_2\text{H}_6\text{S}_2$ and $\text{C}_2\text{H}_6\text{Se}_2$ as alternative precursors have been developed for the growth of TMdCs in metal-organic CVD (MOCVD) [23,24]. Large-area monolayer molybdenum disulfide (MoS$_2$) and tungsten disulfide (WS$_2$) film are readily grown via the proposed MOCVD, but the presence of carbon in the precursors hinders the growth of high quality TMdCs. Therefore, it is still highly necessitated to develop new precursors which do not generate carbon radicals during growth, while ensuring a constant and simultaneous supply of precursors.

Here, we introduce liquid ammonium sulfide ((NH$_4$)$_2$S) as a new reliable and carbon-free sulfur precursor for the growth of transition metal dichalcogenides (TMdS) family. The sulfur flux is precisely controlled by the flow rate of Ar carrier gas through a bubbling system containing the liquid ammonium sulfide. The nucleation density and domain size of MoS$_2$ can be controlled by the flow rate of Ar carrier gas. Furthermore, the continuous supply of ammonium sulfide enables the growth of large-area MoS$_2$ film. Lastly, the growth of WS$_2$ and ReS$_2$ are demonstrated, indicating that ammonium sulfide can be regarded as a universal sulfur precursor for the growth of diverse range of TMdS.

II. Experimental details

MoS$_2$ grains and films were grown using a furnace equipped with a 2-inch quartz tube. As sulfur precursor, a bubbler containing ammonium sulfide solution ((NH$_4$)$_2$S, 40-48 wt% in H$_2$O, Sigma Aldrich) was connected with high purity (99.9999 %) argon gas and to the inlet of the quartz tube. 0.02 M sodium molybdate dihydrate (Na$_2$MoO$_4$·2H$_2$O, ≥99.5 %, Sigma Aldrich) aqueous solution was prepared as the molybdenum precursor. The molybdenum precursor solution was spun onto hydrophilic SiO$_2$/Si substrate with 2500 rpm for 1 min. The molybdenum precursor coated substrate was placed in the center of the quartz tube. To remove residual gas, the quartz tube was purged with 350 sccm argon for 10 min. The temperature of the quartz tube was then elevated to 850 °C in 15 min (~55 °C/min). For growth to commence, 2–20 sccm of argon carrier gas was introduced into the bubbler for 5–20 min. After growth, the supply of (NH$_4$)$_2$S was stopped by a mass flow controller. The quartz tube was rapidly cooled down (~50 °C/min) by taking out the quartz tube from the furnace. The entire growth process was carried out in atmospheric pressure. In the case of the growth of WS$_2$ and ReS$_2$, sodium tungstate dihydrate (Na$_2$WO$_4$·2H$_2$O, ≥99 %, Sigma Aldrich) and sodium perrhenate (NaReO$_4$, 99.99 %, Sigma Aldrich) aqueous solutions were used as transition metal precursors. The growth temperatures for WS$_2$ and ReS$_2$ grains were 850 and 600 °C, respectively. For the growth of ReS$_2$, cleaved mica was used as a growth substrate.

To analyze the lateral size, the number of nucleation and the coverage of MoS$_2$ grains and films, optical microscopy (Eclipse LV150, Nikon) and field emission scanning electron microscopy (FE-SEM, JSM-7100F, JEOL) were used. The thickness and the crystallinity of MoS$_2$ were confirmed via atomic force microscopy (AFM, N8-NEOS, Bruker), micro-Raman spectroscopy and photoluminescence (PL, XperRAM 100, Nanobase) measurements. Silicon probes (Tap 190-G, BudgetSensors) were used for the non-contact mode AFM measurement. During the Raman and PL measurements, 532-nm laser was used with ≤0.1 mW laser power to avoid damages to TMdS.

III. Results and discussion

Figure 1(a) shows the schematic illustration of a CVD system equipped with an (NH$_4$)$_2$S bubbler. The (NH$_4$)$_2$S solution constitutes NH$_4^+$ and S$^2-$ ions required for the growth of TMdS. The amount of (NH$_4$)$_2$S supplied is controlled by the flow rate of argon gas injected into the (NH$_4$)$_2$S bubbler, and the (NH$_4$)$_2$S molecules are thermally decomposed to NH$_3$ and H$_2$S molecules [25]. Therefore, decomposed H$_2$S molecules act as sulfur precursors during the growth of MoS$_2$. According to our previously reported paper, MoS$_2$ grains and films are grown through the sulfurization of Na$_2$MoO$_4$ coated on SiO$_2$/Si substrate [26]. Figure 1(b) shows a photograph of bare SiO$_2$/Si substrate and as-grown MoS$_2$ film. The color of the bare SiO$_2$/Si
substrate is changed to uniform blue-green after growth. Due to the Fresnel effect, the optical color contrast difference between the SiO$_2$/Si substrate and MoS$_2$ grains can clearly be distinguished as shown in Fig. 1(c) [27]. Similar color contrast is observed for all MoS$_2$ grains, indicating a uniform thickness of MoS$_2$ grains is attained. To identify the thickness of grown MoS$_2$ grains, AFM measurement is carried out. Figure 1(d) is an AFM topography image of transferred MoS$_2$ grain indicated by the white-dashed box in [Fig. 1(c)]. The thickness of MoS$_2$ grain is ~0.9 nm, which is well matched with reported value of monolayer MoS$_2$ [28].

Spectroscopic analyses are generally used to investigate the crystallinity of synthetic material. In the case of MoS$_2$, the vibrational energy difference between two MoS$_2$ Raman modes (E$_{2g}^1$ and A$_{1g}$), provides information on the thickness of MoS$_2$ as well as its crystallinity. Figure 1(e) shows the Raman intensity mapping image corresponding to the E$_{2g}^1$ mode of MoS$_2$. Uniform Raman intensity distribution implies uniform thickness of the MoS$_2$ grain. Figure 1(f) displays the representative Raman spectrum extracted from the intensity map. The vibration energy difference ($\Delta\omega$) between E$_{2g}^1$ mode (~386.4 cm$^{-1}$) and A$_{1g}$ mode (~404.7 cm$^{-1}$) is 18.3 cm$^{-1}$, which is in good agreement with the previous report for monolayer MoS$_2$ [26]. It is noted that carbon impurities are not detected on MoS$_2$, while amorphous carbon (a-C) Raman modes are clearly observed on MoS$_2$ grown by organic liquid precursor [23]. Figure 1(g) shows a PL spectrum of transferred MoS$_2$ grain. Higher PL intensity than MoS$_2$ Raman signal is observed at the MoS$_2$ grain, which is another indicator for monolayer MoS$_2$ [6]. To confirm the crystallinity of MoS$_2$, the PL spectrum is deconvoluted by three Lorentzian curves at 1.852 eV (A, multie exciton), 1.895 eV (A$^0$, neutral exciton), and 1.988 eV (B, neutral exciton), respectively [23]. The full width half maximum value of A$^0$ exciton is ~37.8 meV, which is similar to the value of mechanical exfoliated MoS$_2$ [29]. This suggests that high-quality MoS$_2$ grains and films are grown with liquid (NH$_4$)$_2$S precursor.

One of the great advantages of the liquid precursor is controllability. Based on the controllability of the liquid (NH$_4$)$_2$S precursor, the growth kinetics of MoS$_2$ is studied by controlling of the flow rate of (NH$_4$)$_2$S. Figures 2(a)-(d) present the optical microscopy images of as-grown MoS$_2$ grains with different (NH$_4$)$_2$S supply of 2, 5, 10, and 20 sccm, respectively. With 2 sccm of (NH$_4$)$_2$S flow rate, various sizes of MoS$_2$ grains are observed, indicating that the nucleation of MoS$_2$ grains occurs at different stages with continuous supply of (NH$_4$)$_2$S. On the contrary, more uniform lateral size is observed at 20 sccm, implying that the nucleation of MoS$_2$ grains occurs at similar stages with continuous supply of (NH$_4$)$_2$S. On the contrary, more uniform lateral size is observed at 20 sccm, implying that the nucleation of MoS$_2$ grains occurs at similar stages with continuous supply of (NH$_4$)$_2$S. On the contrary, more uniform lateral size is observed at 20 sccm, implying that the nucleation of MoS$_2$ grains occurs at similar stages with continuous supply of (NH$_4$)$_2$S. On the contrary, more uniform lateral size is observed at 20 sccm, implying that the nucleation of MoS$_2$ grains occurs at similar stages with continuous supply of (NH$_4$)$_2$S.
rate of (NH$_4$)$_2$S is decreased from ~123 to 54 µm, the number of MoS$_2$ grains per unit area (10,000 µm$^2$) is increased from 0.87 to 4.01. This is attributed to the increment of the concentration of precursor, which was typically observed in the growth of 2D materials such as graphene and hBN [30,31]. These results further prove that the supply of (NH$_4$)$_2$S is successfully controlled by the bubbler system.

Another advantage of the liquid precursor is the sustainable supply of the precursor molecules. Therefore, time-dependent growth is performed to confirm the continuous supply of (NH$_4$)$_2$S precursor. Figures 3(a)-(d) show optical microscopy images of as-grown MoS$_2$ grains and films for 5, 10, 15, and 20 min, respectively. The lateral size of MoS$_2$ grains grown for 5 min is ~40 µm, indicating that the growth rate at the initial stage is very high (~160 µm$^2$/min). At 10 min, the grain size increases to ~60 µm, while the number of MoS$_2$ grains is maintained. It implies that the continuous supply of (NH$_4$)$_2$S precursor contributes to the increase in size of the grown MoS$_2$ grains instead of forming new nucleation sites. With further
thickness is also observed at 1L MoS₂. This originates from the direct band gap transition in 1L MoS₂, which is clearly observed at 2L and FL MoS₂.

Further growths of bilayer and few-layer MoS₂ are observed. Figure 3(e) shows the statistics of mono-, bi-, and FL MoS₂ layers. The percentage of mono-layer MoS₂ is already ~70%, and linearly increased to 100% in 15 min. The coverage of both 2L and FL MoS₂ grains increase with increasing of the growth time. To analyze the grown MoS₂ film, the growth kinetics are studied by controlling the precursor flow rate and the growth time. The lateral size and the number of nucleation sites of MoS₂ grains are controlled by the flow rate of MoO₃ precursor.

In order to confirm the versatility of (NH₄)₂S precursor, the growth of tungsten disulfide (WS₂) is demonstrated. Na₂WO₄:2H₂O aqueous solution is used as tungsten precursor instead of the use of Na₂MoO₄:2H₂O solution. Figure 4(a) shows an optical microscopy image of as-grown WS₂ grains. Equilateral triangular shaped WS₂ grains are grown with uniform grain size (~10 µm). Two representative WS₂ phonon modes (2LA (M) mode at 349.2 cm⁻¹ and A₁g mode at 415.3 cm⁻¹) are clearly observed in the Raman spectrum as shown in Fig. 4(b). The Δω value between the two modes is ~66 cm⁻¹, which is similar to the previously reported Δω value of monolayer WS₂ [32]. As another example, the growth of rhenium disulfide (ReS₂) is carried out by sulfurization of the NaReO₄ coated substrate. Figure 4(c) shows an optical microscopy image of circular-shaped ReS₂ grains grown on sapphire substrate. The observed circular shape of ReS₂ grains might be attributed to the high diffusion of adatoms which originates from the higher growth temperature at 600 °C than previously reported growth of hexagonal grains at 450 °C [33]. Similar growths of other circular shaped 2D materials are observed at higher growth temperature [21]. To identify the layer thickness of ReS₂ grains, Raman spectroscopy measurement is carried out. Figure 4(d) shows a Raman spectrum of ReS₂ grains transferred on SiO₂/Si substrate. Two ReS₂ phonon modes are clearly observed at ~154 (E₁g mode) and ~212.7 cm⁻¹ (A₁g mode). Additionally, very weak E₁g like Raman modes are observed between 280–380 cm⁻¹, which is well in agreement with previously reported 1L ReS₂ Raman signals [33]. Therefore, both 1L WS₂ and ReS₂ grains are successfully grown with the use of (NH₄)₂S liquid precursor. Consequently, our proposed (NH₄)₂S liquid precursor can be used as a universal sulfur precursor for the growth of other TMdS.

IV. Conclusions

In summary, we report the use of liquid (NH₄)₂S solution as a universal sulfur precursor for CVD growth of TMdS. Based on the advantage of the liquid precursor, the growth kinetics are studied by controlling the precursor flow rate and the growth time. The lateral size and the number of nucleation sites of MoS₂ grains are controlled by the flow rate of (NH₄)₂S precursor. With increasing of the growth time
to 15 min, centimeter-scaled MoS$_2$ film is successfully grown. After further supply of (NH$_4$)$_2$S precursor, the growth of MoS$_2$ is governed by the Stranski-Krastanov model. Furthermore, the growth of WS$_2$ and ReS$_2$ using (NH$_4$)$_2$S precursor are also demonstrated. We believe that our approach not only open a facile way for the high quality reliable growth of TMdS but also helps the commercialization of TMdS in the near future.

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References